

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10629596	SHIOZAWA ET AL.
	Examiner	Art Unit
	Tu, Julia P	2611

SEARCHED

Class	Subclass	Date	Examiner
375	295	11/18/2006	J.T.
370	466	11/18/2006	J.T.
375	371, 376,316	4/17/2007	J.T.
327	147	4/17/2007	J.T.
370	395.62,395.6,503,314,328,156,474,545	4/17/2007	J.T.

SEARCH NOTES

Search Notes	Date	Examiner
Inventors name searched	11/18/2006	J.T.
Searched on East using US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM TDB	11/18/2006	J.T.
Searched on Google, IEEE	11/20/2006	J.T.
Consulted with Chieh Fan and Khanh Tran	11/20/2006	J.T.
Consulted with Chau Nguyen, SPE (370) on the allowance of claims 4-6	11/21/2006	J.T.
update search on East	4/17/2007	J.T.
consult with Chieh Fan	4/17/2007	J.T.

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
370	395.62,395.6,503,314,328,156,474,545	4/17/2007	J.T.
375	371,376,316	4/17/2007	J.T.
327	147	4/17/2007	J.T.